### Qualification in Accordance With AEC-Q100†

- Qualified for Automotive Applications
- Customer-Specific Configuration Control Can Be Supported Along With Major-Change Approval
- Wide Operating Voltage Range of 2 V to 6 V
- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 40-μA Max I<sub>CC</sub>
- Typical t<sub>pd</sub> = 8 ns
- ±4-mA Output Drive at 5 V
- Low Input Current of 1 μA Max

#### D OR PW PACKAGE (TOP VIEW) 14 🛮 V<sub>CC</sub> 1B **1**2 13**∏** 4B 1Y **∏** 3 12 | 4A 11 🛮 4Y 2A 2B 5 10 3B 2Y 🛮 6 9 🛮 3A GND [] 7 8 3Y

### description/ordering information

The SN74HC00 device contains four independent 2-input NAND gates. It performs the Boolean function  $Y = \overline{A} \bullet \overline{B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

### ORDERING INFORMATION

TA	PACKAGE <sup>‡</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
4000 1- 40500	SOIC - D	Reel of 2500	SN74HC00QDRQ1	HC00Q
-40°C to 125°C	TSSOP - PW	Reel of 2000	SN74HC00QPWRQ1	HC00Q

<sup>‡</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

# FUNCTION TABLE (each gate)

INP	JTS	OUTPUT
Α	В	Y
Н	Н	L
L	Χ	Н
Х	L	Н

### logic diagram (positive logic)





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



<sup>&</sup>lt;sup>†</sup>Contact factory for details. Q100 qualification data available on request.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note 1)	$\dots \dots \pm 20 \text{ mA}$
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) (see Note 1)	$\dots \dots  \pm 20 \text{ mA}$
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): D package	86°C/W
PW package	113°C/W
Storage temperature range, T <sub>Stg</sub>	65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions (see Note 3)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			
$V_{IH}$	V <sub>IL</sub> Low-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15			V
		V <sub>CC</sub> = 6 V	4.2			
		V <sub>CC</sub> = 2 V			0.5	
٧ <sub>IL</sub>	V <sub>IL</sub> Low-level input voltage	$V_{CC} = 4.5 \text{ V}$			1.35	V
		V <sub>CC</sub> = 6 V			1.8	
٧ <sub>I</sub>	Input voltage		0		VCC	V
٧o	Output voltage		0		VCC	V
		V <sub>CC</sub> = 2 V			1000	
Δt/Δν	Input transition rise/fall time	V <sub>CC</sub> = 4.5 V			500 n:	ns
	V <sub>CC</sub> = 6 V				400	
TA	Operating free-air temperature	•	-40		125	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

24244555	TEGT CONDITIONS		.,	T <sub>A</sub> = 25°C					
PARAMETER	TEST CONDITION	ONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		
		$I_{OH} = -20  \mu A$	4.5 V	4.4	4.499		4.4		
Vон	VI = VIH or VIL		6 V	5.9	5.999		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		
	VI = VIH or VIL	I <sub>OL</sub> = 20 μA	2 V		0.002	0.1		0.1	
			4.5 V		0.001	0.1		0.1	
VOL			6 V		0.001	0.1		0.1	V
		I <sub>OL</sub> = 4 mA	4.5 V		0.17	0.26		0.4	
		$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4	
IĮ	VI = VCC or 0		6 V		±0.1	±100		±1000	nA
ICC	$V_I = V_{CC}$ or 0,	IO = 0	6 V			2		40	μΑ
Ci			2 V to 6 V		3	10		10	pF

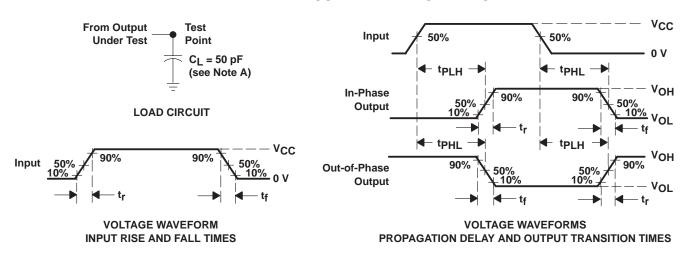
# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	١,,	T <sub>A</sub> = 25°C					LINUT
	(INPUT)		VCC	MIN	TYP	MAX	MIN	MAX	UNIT
<sup>t</sup> pd	A or B	Y	2 V		45	90		135	ns
			4.5 V		9	18		27	
			6 V		8	15		23	
t <sub>t</sub>		Y	2 V		38	75		110	
			4.5 V		8	15		22	ns
			6 V		6	13		19	

## operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per gate	No load	20	pF

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

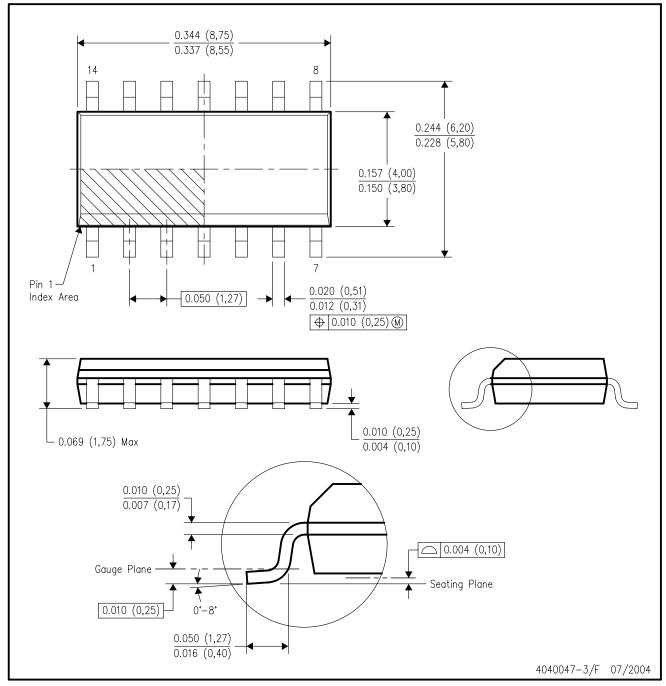
- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \ \Omega$ ,  $t_\Gamma = 6 \ ns$ ,  $t_f = 6 \ ns$ .
- C. The outputs are measured one at a time, with one input transition per measurement.
- D.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Figure 1. Load Circuit and Voltage Waveforms



## D (R-PDSO-G14)

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

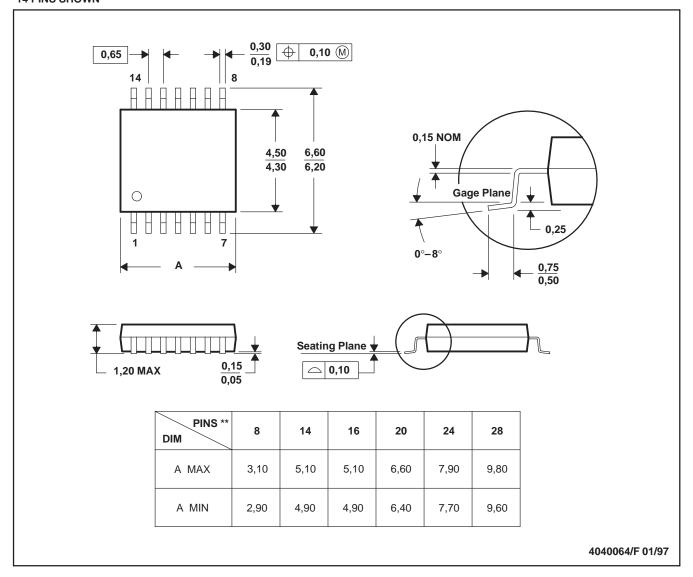
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AB.



### PW (R-PDSO-G\*\*)

### 14 PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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